

Errant Beam Update

Accelerator Advisory
Committee

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7 May 2013

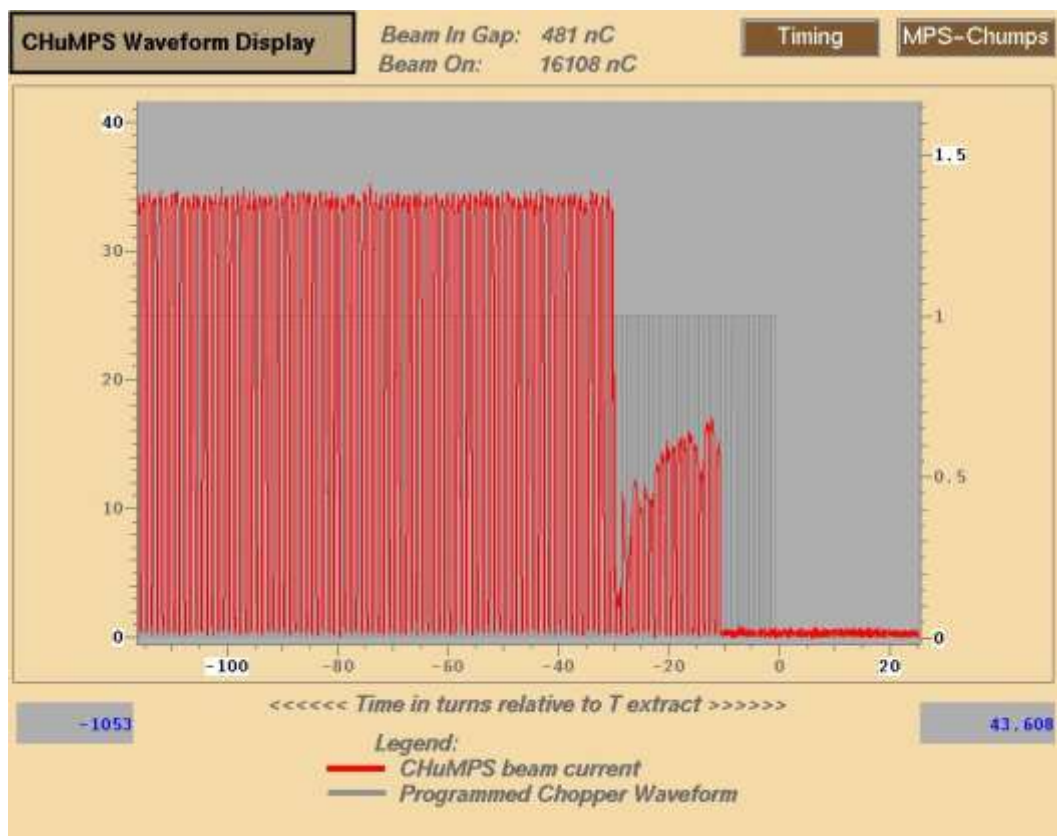


Why is errant beam important

- Errant beam mechanism
 - Beam hitting cavity surface desorbs gas or particulates creating an environment for arcing
- Super Conducting Linac (SCL) cavity performance degrades over time
 - SCL cavities do not trip with every errant beam pulse, but the probability for a trip increases with time
 - Cavity fields have been lowered and cavities have been turned off which results in lower beam energy
- SCL cavity performance degradation from errant beam can be restored (except for cavity 06c)
 - Requires cavity warm up during a long shutdown and then RF conditioning before beginning beam operation
 - Cryomodules have been removed from the tunnel for cavity RF coupler repairs but this takes months

Our definition of errant beam

- Abrupt beam loss caused by
 - Low current or partial beam pulses
 - Beam pulses with incorrect energy
- SCL Beam Loss Monitors (BLM) are the primary indication of errant beam



Fast beam current monitor in MEBT

Machine Protection System (MPS) contributed to errant beam conditions

- Discovered in 2009 that problems with MPS system were contributing to SCL cavity performance degradation
 - When a fault occurred, in some instances 300 microseconds or more of beam was accelerated before MPS turned beam off (goal is 25 microseconds)
 - Long delays found throughout MPS
 - Root cause traced to low pass filters added to reduce false trips due to electrical noise – fixed in early 2010 by removing filters
- Also reduced set point for number of BLM trips in 1 second needed to shut off beam (“chatter faults”, reduced from 2 to 1)
- Also reduced BLM trip limits

In response to the AAC the errant beam taskforce was established

- Correcting the MPS and tightening BLM limits reduced the impact of errant beams but did not eliminate them
- SCL cavity performance continued to degrade
- In February 2012 a task force was created to further understand the errant beam mechanisms
- Plans for the taskforce were
 - Measure errant beam
 - How much is being lost
 - How often it is occurring
 - Find the causes for errant beam
 - Reduce errant beam faults
 - Reduce the impact of errant beam

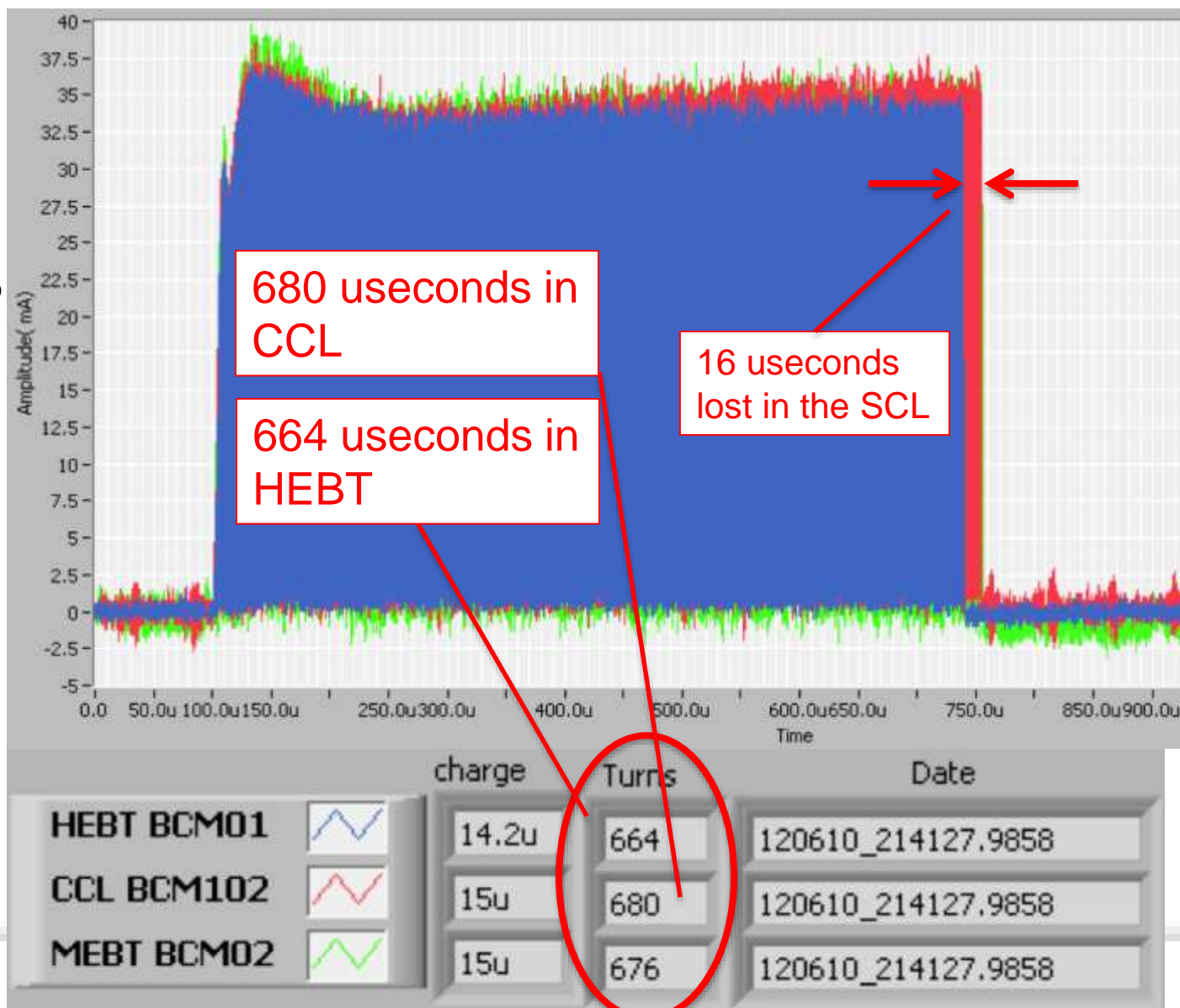
Beam diagnostics used

- Differential Beam Current Monitor (BCM) systems
 - Use BCMs in the MEBT, CCL, and HEBT to see how much beam is lost in the SCL
- BLM systems
 - 76 ion chamber detectors along the SCL
- Automated report system
 - SCL BLM trip occurs
 - Record BCM waveforms, BLM waveforms, BLM signal level
 - Send data to a webserver for immediate viewing

How much beam is lost

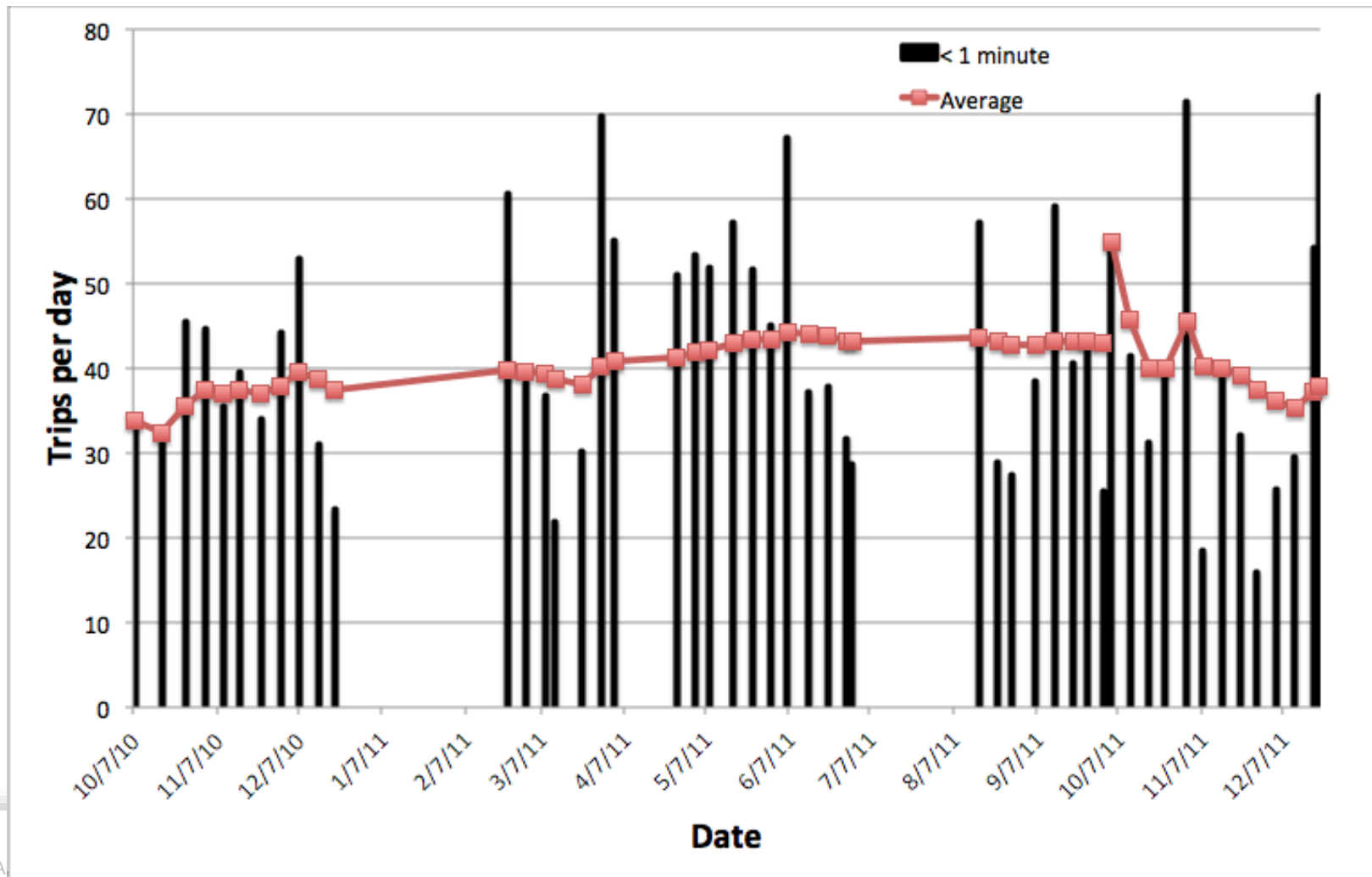
16 useconds
End of DTL = 30 J
End of CCL = 66 J
End of SCL = 350 J

- Differential BCMs showed different types of faults
 - Averaged 15-20 usec of beam lost in the SCL
- Verified MPS is working properly

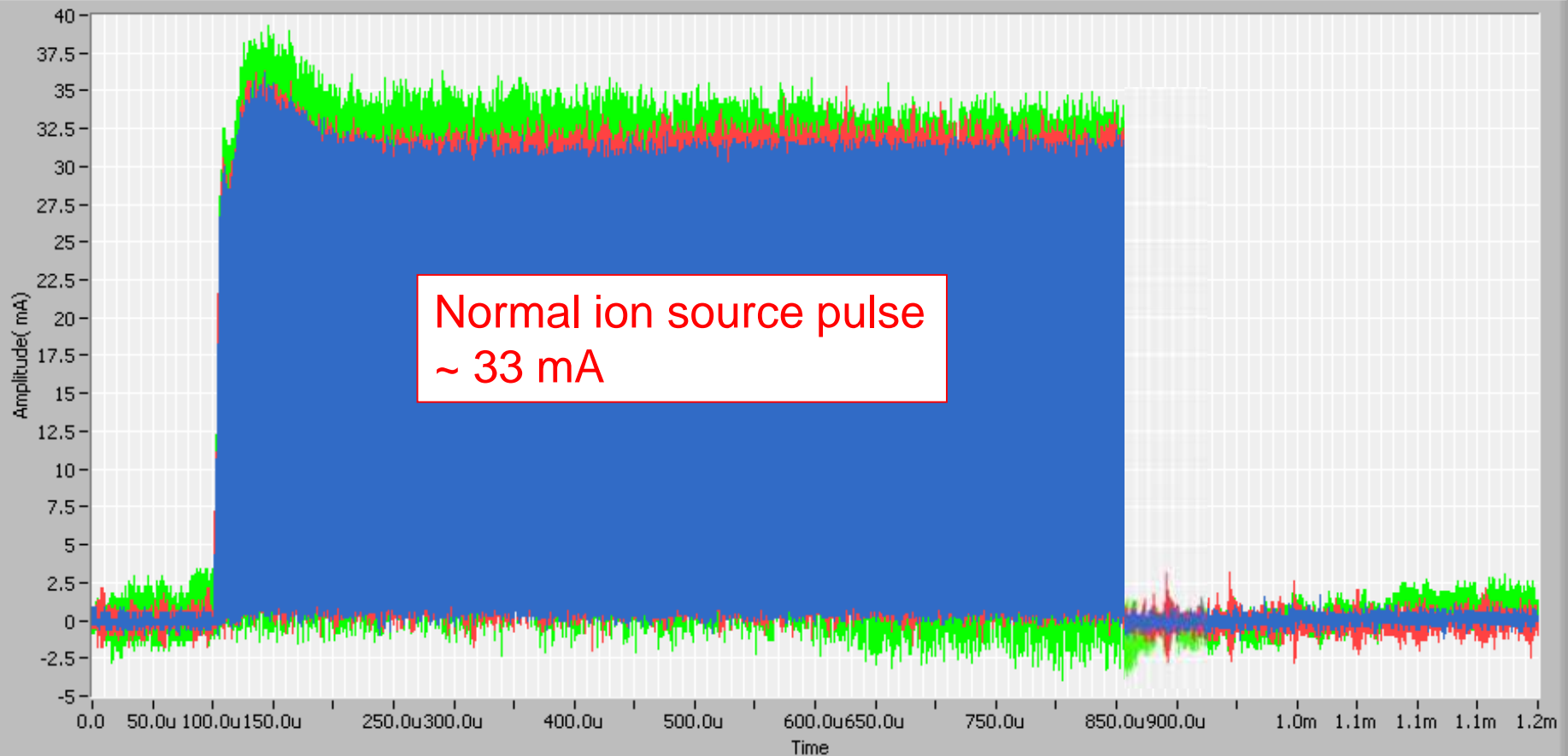


Short beam trips and errant beam

- September 2010 to December 2011
 - On average >75% (30 per day) of short trips were caused by errant beam



Ion source/LEBT is one cause of errant beams



Normal ion source pulse
~ 33 mA

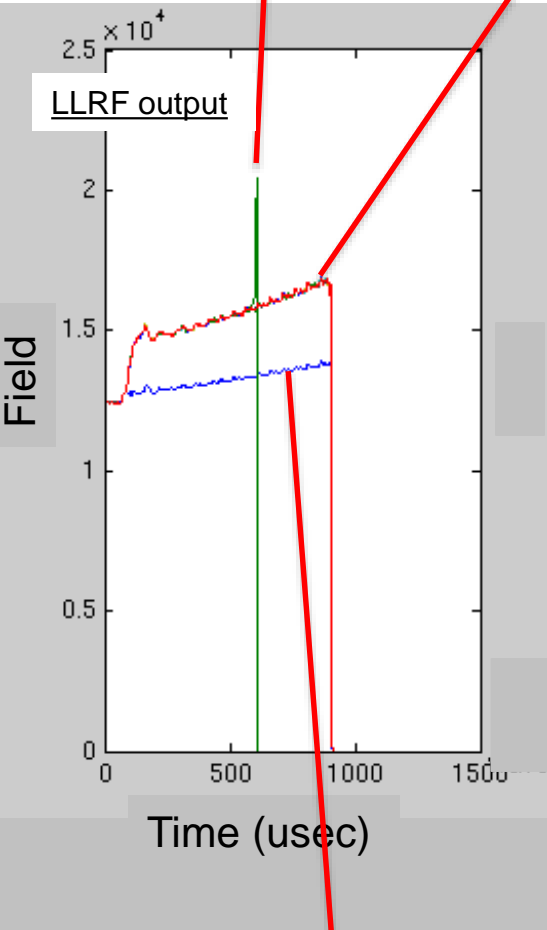


HEBT BCM01	
CCL BCM102	
MEBT BCM02	

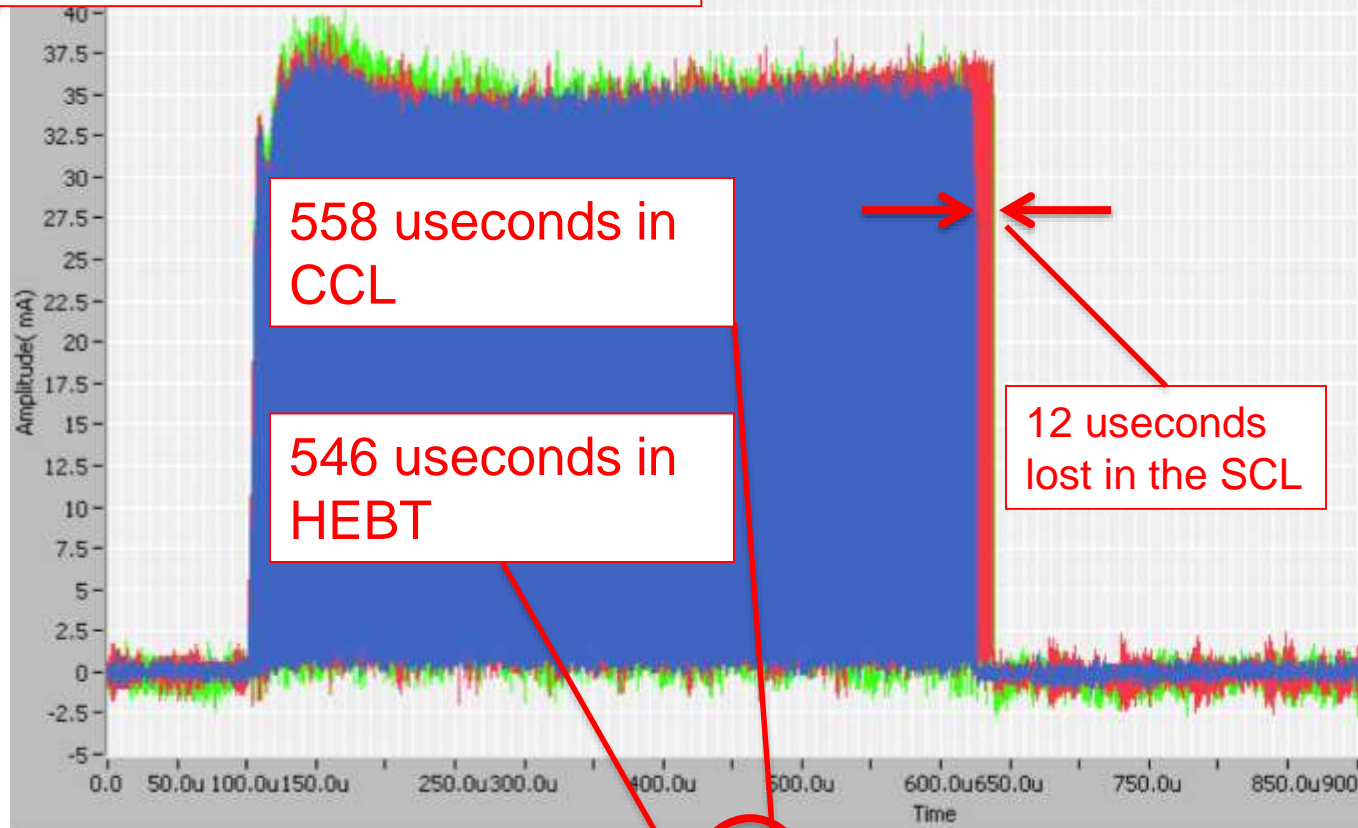
File 120510_212641.png

Warm Linac RF are the other causes

Abnormal RF pulse with beam



Normal RF pulse with beam



	charge	Turns	Date
HEBT BCM01	11.9u	546	120612_190535.8754
CCL BCM102	12.5u	558	120612_190535.8754
MEBT BCM02	12.6u	555	120612_190535.8754

Normal RF pulse with no beam

The majority of trips originate in the Warm Linac

- < 10% of BLM trips were due to the Ion source/LEBT
 - Most ion source induced BLM trips occur during the first week of a new source installation
 - High voltage arcing
- > 90% of BLM trips were due to Warm Linac RF faults
 - RF faults occur at different times during the pulse
 - Faults during the RF fill had reproducible times
 - Faults during the RF flattop were random
 - Focused on improving warm linac operation

RF fill faults can be reduced

- Adjust the RF field
 - Move below or above multipacting band
- Adjust RF fill time
 - Ramp speed through multipacting bands
- Change cavity resonant frequency
 - Move multipacting band
- Vacuum maintenance
 - Maintain low vacuum near RF window

DURING BEAM
OPERATION

Resonant frequency change improves trip rate

Plot shows 5 days

Repeated RF faults

Reduced RF faults due to vacuum

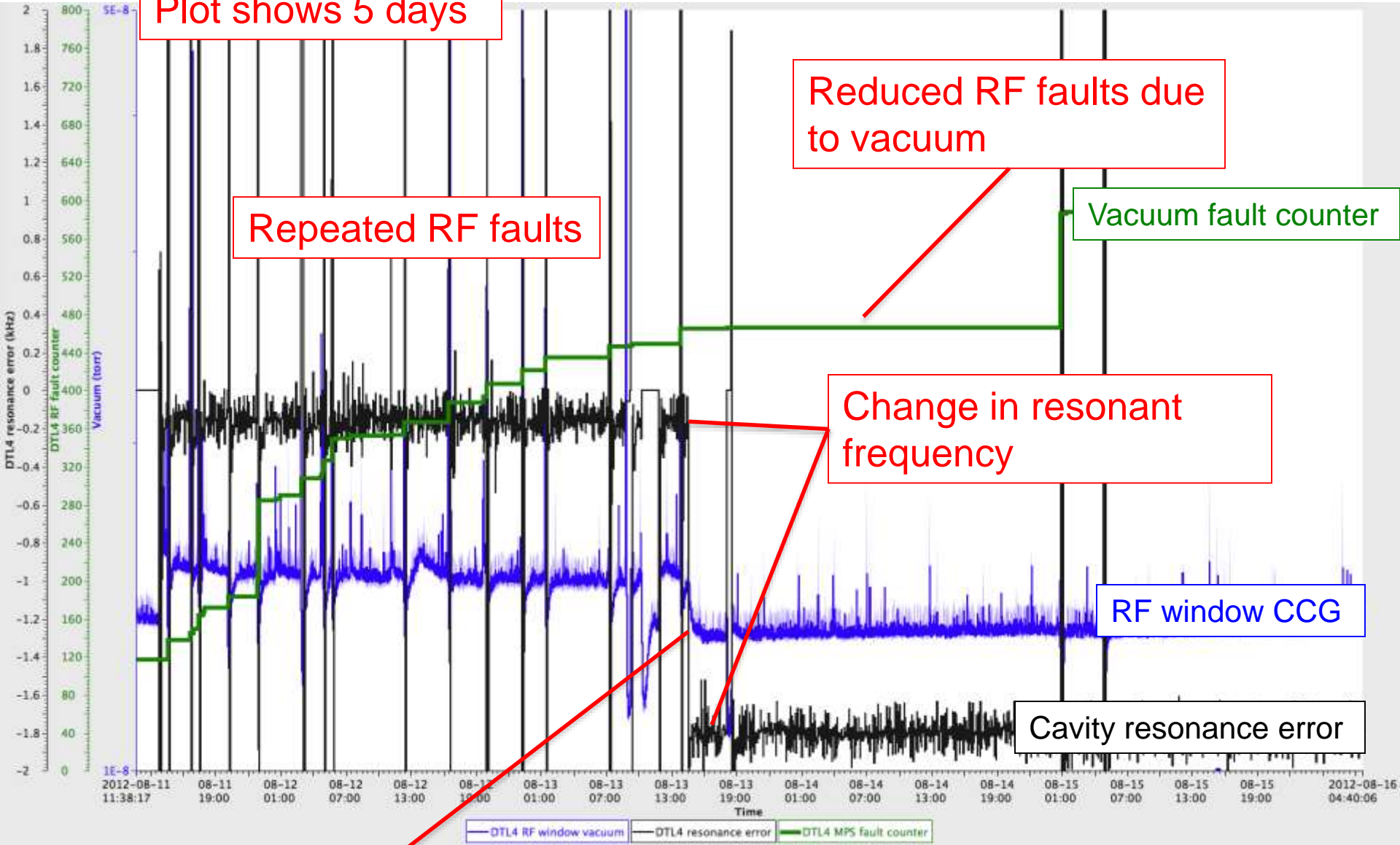
Vacuum fault counter

Change in resonant frequency

RF window CCG

Cavity resonance error

RF window vacuum level drops



Non-Evaporable Getter regeneration improves trip rate

Plot shows 18 days

RF on

RF gradient

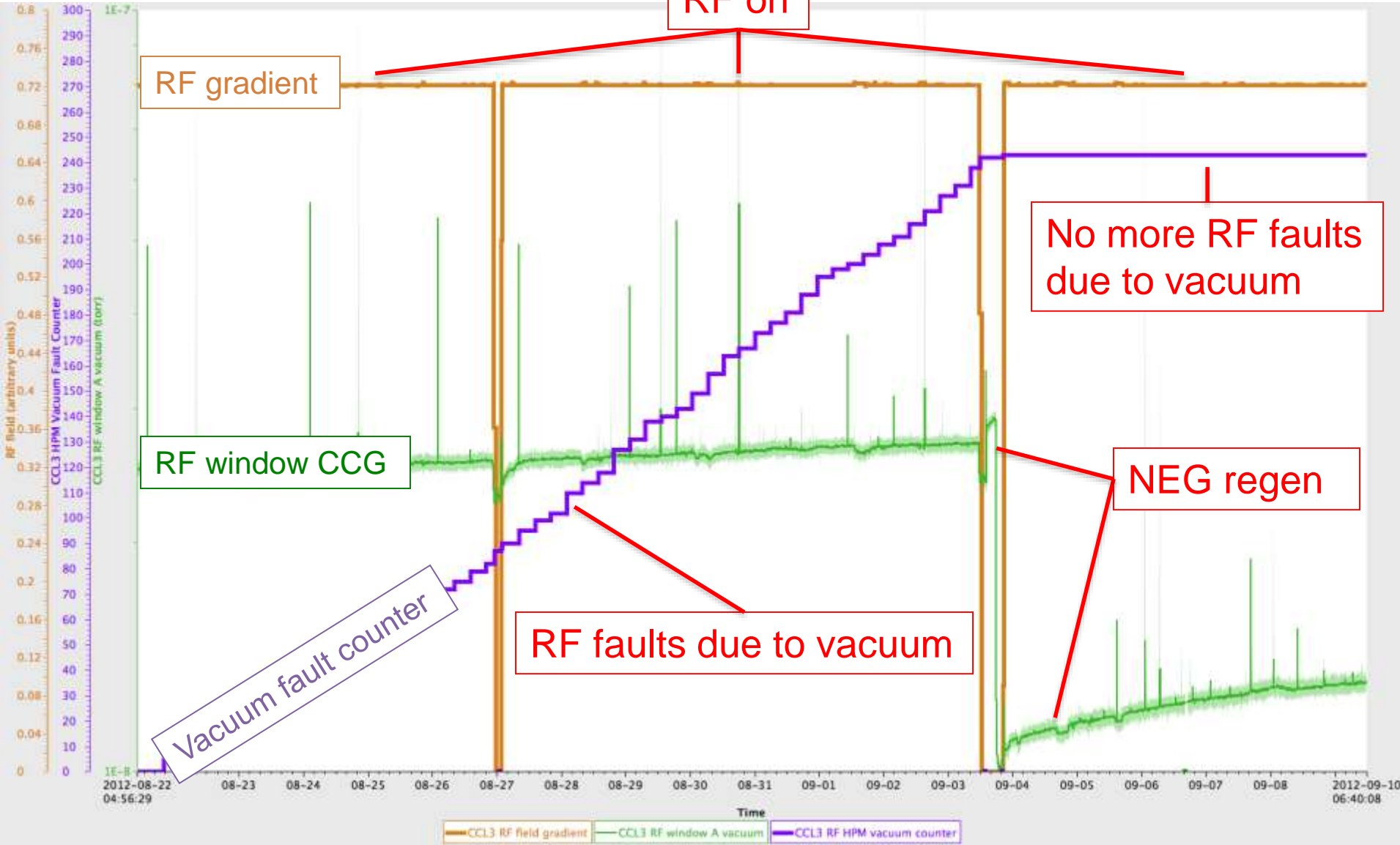
No more RF faults due to vacuum

RF window CCG

NEG regen

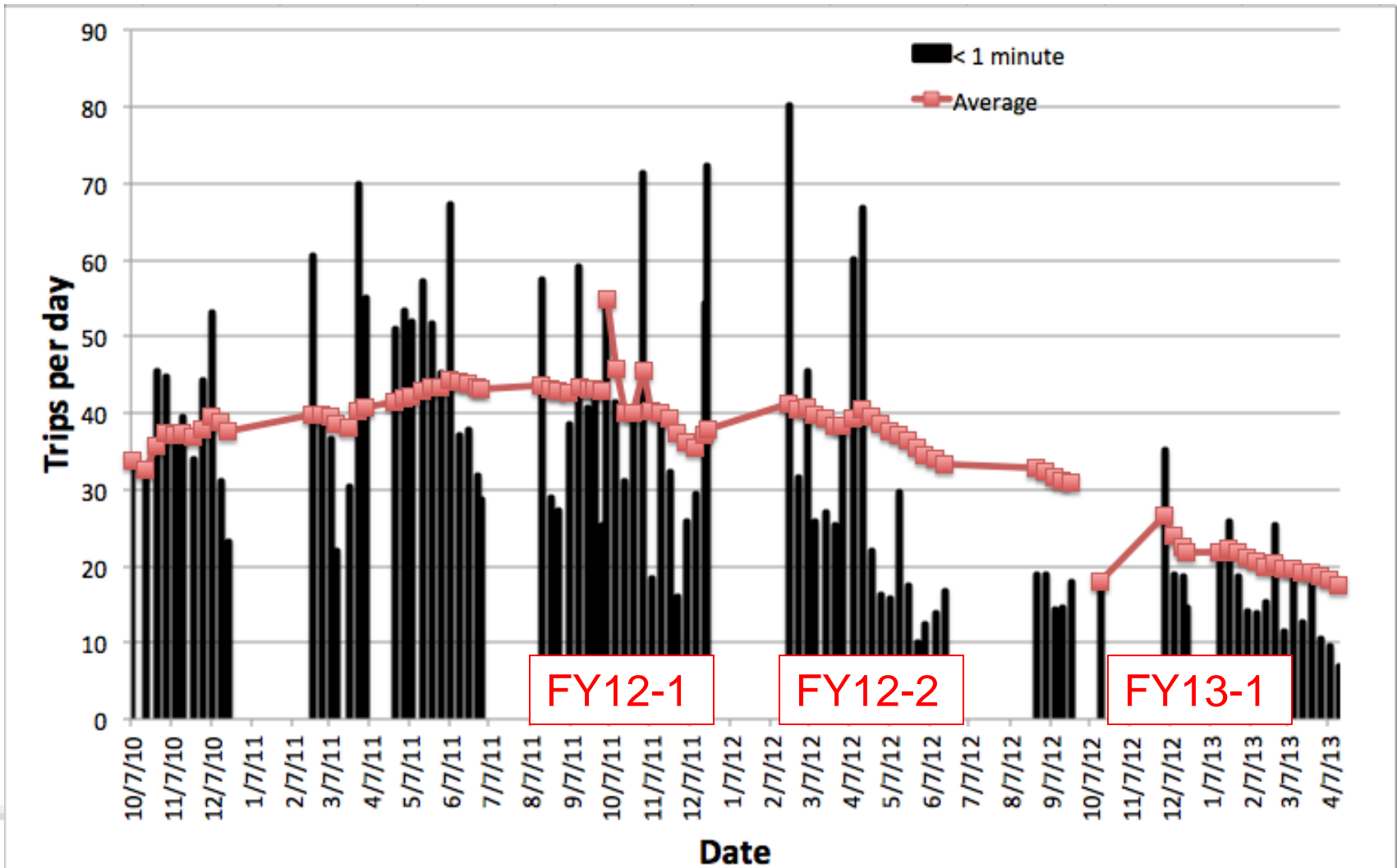
Vacuum fault counter

RF faults due to vacuum



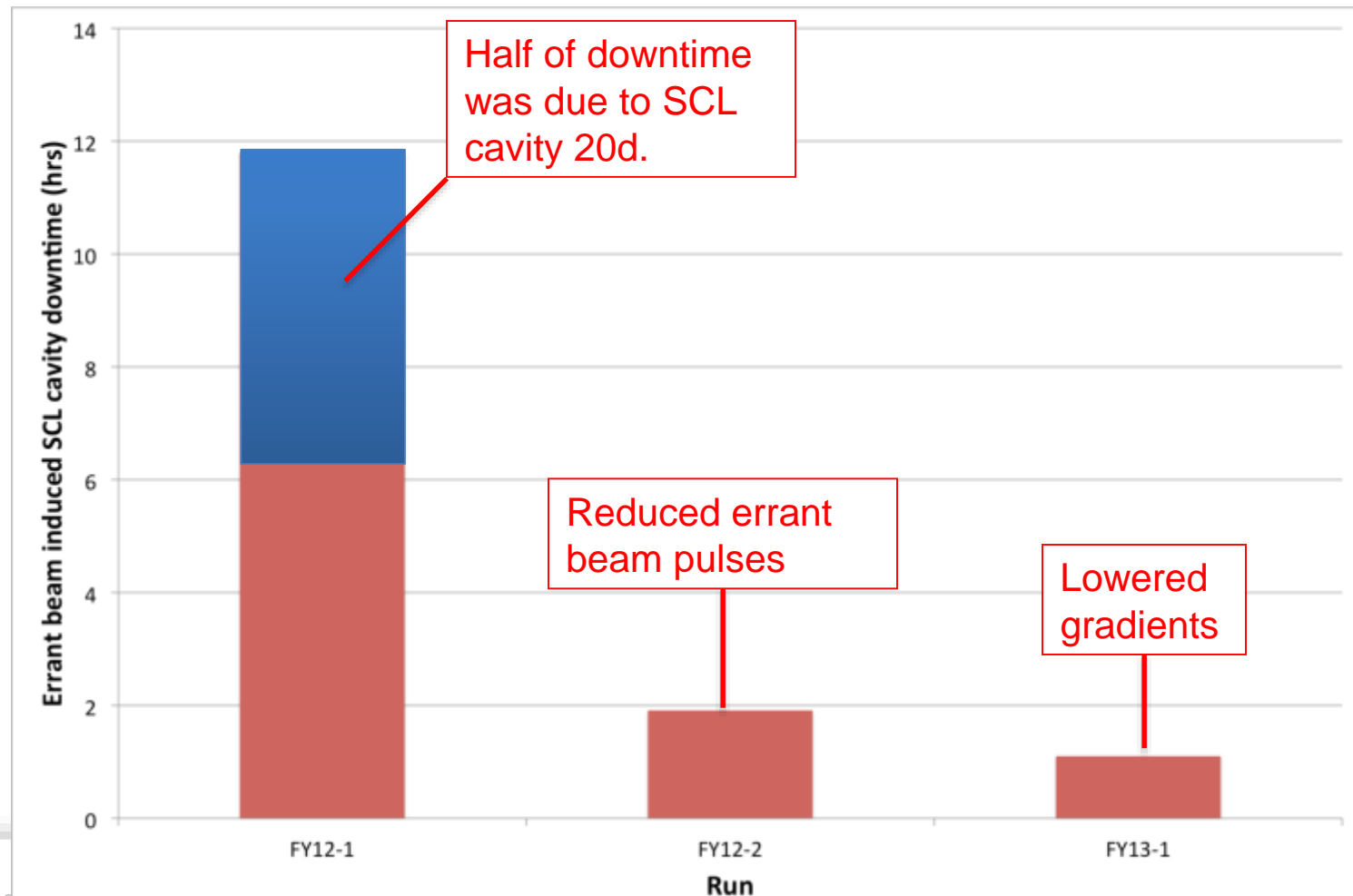
Errant beam trips reduced

- By May 2012
 - < 15 errant beam pulses per day




SCL cavity downtime reduced 6x

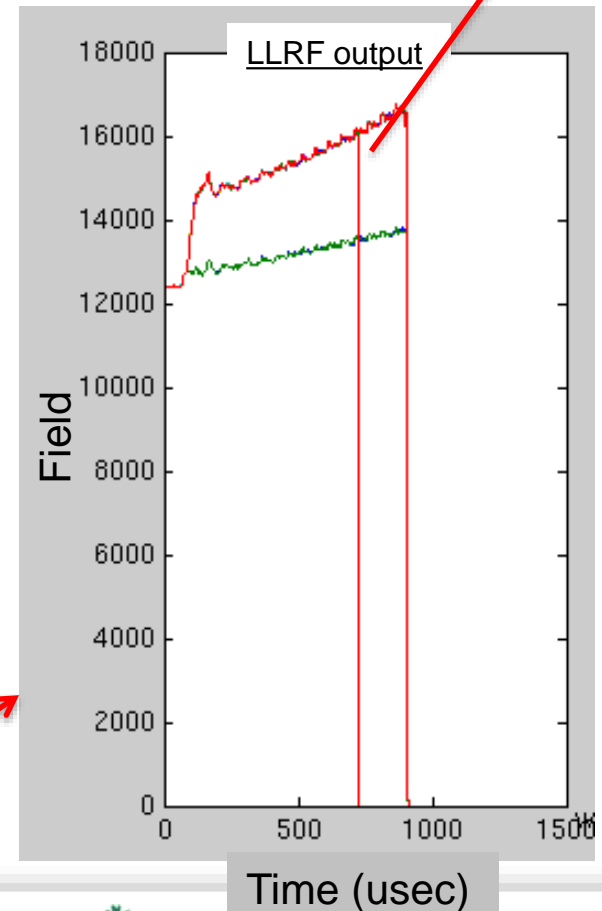
- Reducing errant beam pulses reduced errant beam induced SCL cavity downtime by factor of 3
- Lowering the gradient on problematic cavities reduced downtime by factor of 2
 - Lowering gradients a few percent is done during beam operation



Future plans to further reduce the impact

Loss of LLRF drive

- Decrease the response time of the MPS for errant beam
 - Add SCL differential BCM system (CCL and HEFT) to MPS
 - Add dedicated line to MPS (minimal delays)
 - Goal is beam off time of 5 microseconds
 - Summer 2013
- Ion source pulse by pulse discriminator
 - If ion source pulse differs significantly from the previous then turn beam off
- Further reduce Warm Linac RF faults
 - One type of unexplained RF fault remaining 

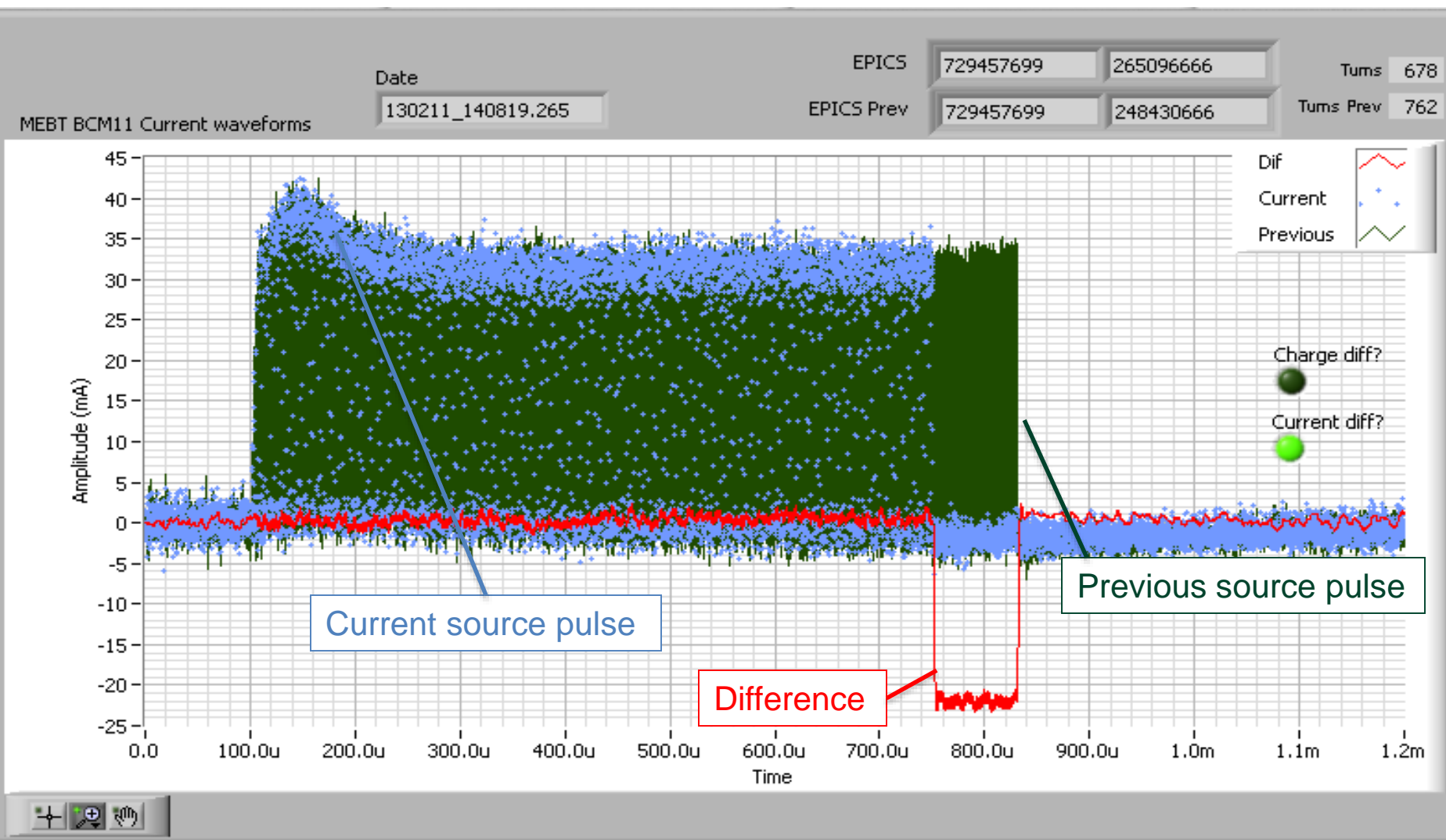


Summary

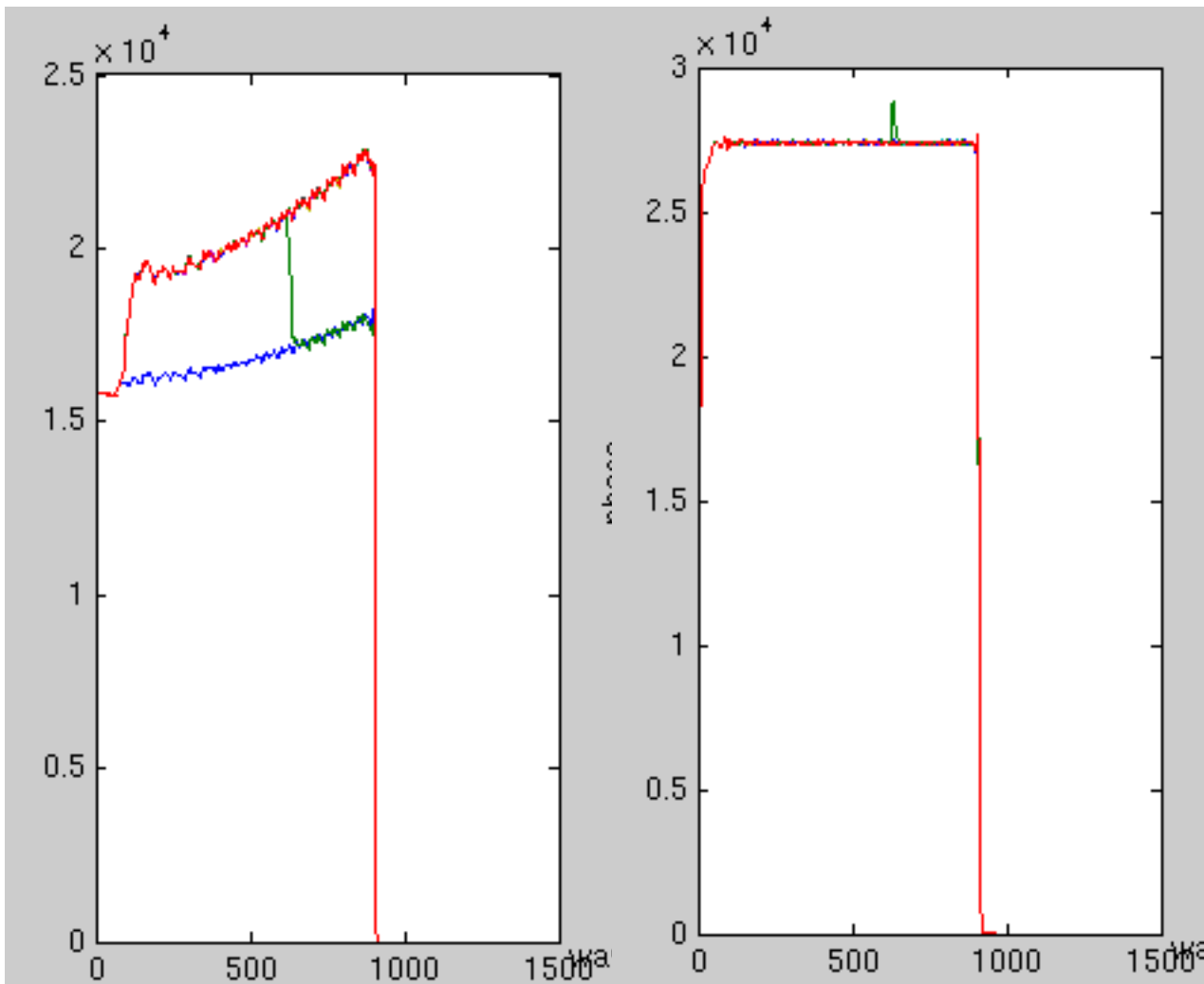
- Errant beam BLM trips have been reduced by $> 2x$
- Continuing to mitigate errant beams
 - Ion source/LEBT high voltage and RF conditioning
 - Routine maintenance of vacuum systems
 - Operational experience with DTL and CCL cavities
- Cavity degradation continues
 - Lowering gradients helps reduce downtime
 - Cavity warm up and conditioning during long shutdowns
- Reduction in MPS beam turn off time coming in summer 2013
- Protection of the SCL against performance degradation is much more challenging than initially expected

Additional slides

Example of ion source pulse by pulse differential BCM

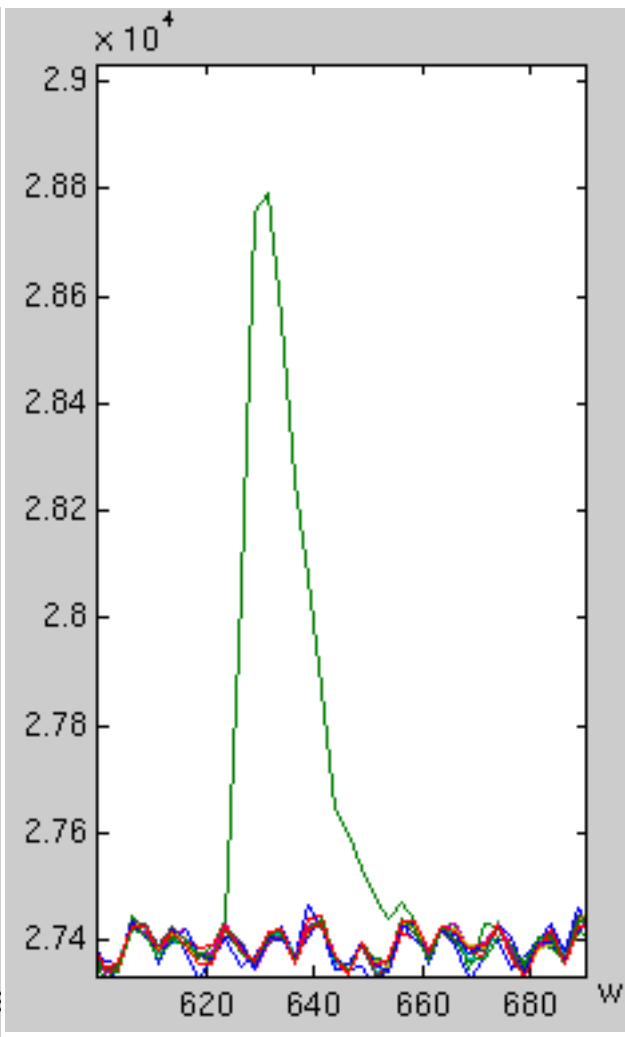


Normal RF waveforms during SCL BLM trip



RF Drive

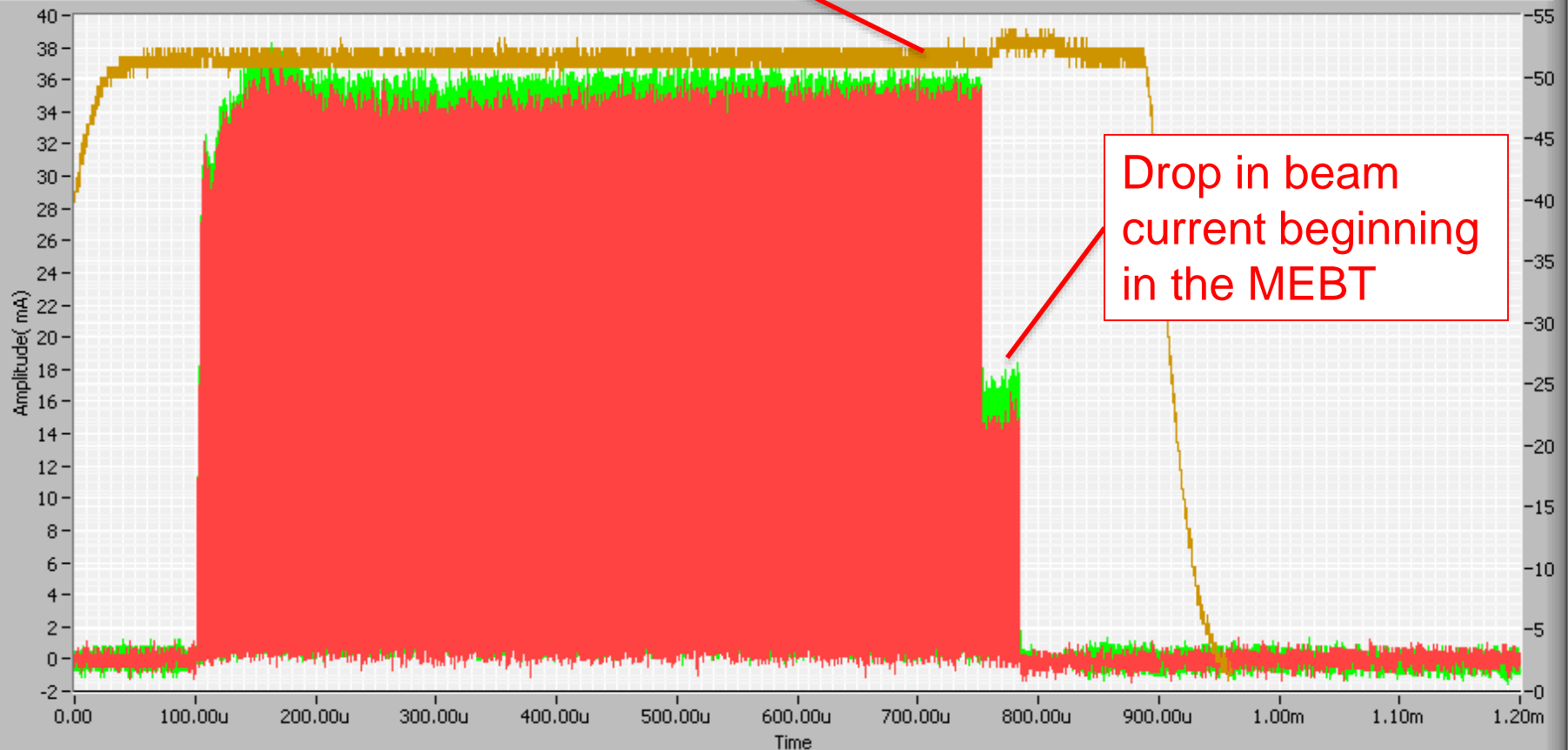
Cavity field



Cavity field zoomed

Ion source/LEBT errant beam example

DTL4 RF waveform



	charge	Turns	Date
RF-DTL4	16u	817	121207_172541.82
RF-DTL5	13.1u	707	121207_172541.248
HEBT-BCM01	0	0	
CCL-BCM102	13.2u	714	121207_172541.248
MEBT-BCM02	14u	714	121207_172541.248

Time

Amplitude(mA)

File 121207_172541.png

HEBT BCM01 was not working for this case

Warm Linac cavity response with beam current drop

